

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 116194		APPLICATION NO. 10/607,129	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANTS Toshitaka IWAGO et al.			
				FILING DATE June 27, 2003			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
<i>DB</i>	1	6,321,063 B1	11/2001	Tanaka et al.			
<i>DB</i>	2	D456,834 S	05/2002	Fetherolf et al.			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
<i>DB</i>	3	JP 3205734 B2 (w/abstract and translation)	06/29/2001	Japan			
<i>DB</i>	4	JP 2002-171372 A (w/abstract, explanation and translation)	06/14/2002	Japan			
<i>DB</i>	5	JP 2002-62704 A (w/abstract, explanation and translation)	02/28/2002	Japan			
<i>DB</i>	6	JP 2002-300369 A (w/abstract, explanation and translation)	10/11/2002	Japan			
<i>DB</i>	7	2002-362814 (w/abstract, explanation and translation)	12/18/2002	Japan			
<i>DB</i>	8	6-61844 (w/explanation)	9/2/1994	Japan			
<i>DB</i>	9	5-1755 (w/ explanation)	1/14/1993	Japan			
<i>DB</i>	10	10-330015 (w/abstract, explanation and translation)	12/15/1998	Japan			
<i>DB</i>	11	11-157732 (w/abstract, explanation and translation)	6/15/1999	Japan			
<i>DB</i>	12	6-10064 (w/abstract and explanation)	2/9/1994	Japan			
<i>DB</i>	13	2-10349 (w/ explanation)	1/23/1990	Japan			
<i>DB</i>	14	7-21467 (w/ explanation)	5/17/95	Japan			
<i>DB</i>	15	62-153059 (w/abstract and explanation)	7/8/1987	Japan			
EXAMINER <i>[Signature]</i>					DATE CONSIDERED 03-15/2005		
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